

Notice of References Cited	Application/Control No. 10/708,792	Applicant(s)/Patent Under Reexamination NAKAMURA ET AL.	
	Examiner Ha T. Nguyen	Art Unit 2812	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2005/0045947 A1	03-2005	Chen et al.	257/336
	B	US-6,881,635 B1	04-2005	Chidambarao et al.	438/300
	C	US-			
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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